



Phase Control Thyristor

Types B1115LC160 and B1115LC180

Absolute Maximum Ratings

	VOLTAGE RATINGS	MAXIMUM LIMITS	UNITS
V _{DRM}	Repetitive peak off-state voltage, (note 1)	1600-1800	V
V _{DSM}	Non-repetitive peak off-state voltage, (note 1)	1600-1800	V
V _{RRM}	Repetitive peak reverse voltage, (note 1)	1600-1800	V
V _{RSM}	Non-repetitive peak reverse voltage, (note 1)	1700-1900	V

	OTHER RATINGS	MAXIMUM LIMITS	UNITS
I _{T(AV)}	Mean on-state current. T _{sink} =55°C, (note 2)	1157	A
I _{T(AV)}	Mean on-state current. T _{sink} =85°C, (note 2)	820	A
I _{T(AV)}	Mean on-state current. T _{sink} =85°C, (note 3)	495	A
I _{T(RMS)}	Nominal RMS on-state current. T _{sink} =25°C, (note 2)	2260	A
I _{T(d.c.)}	D.C. on-state current. T _{sink} =25°C, (note 4)	1940	A
I _{TSM}	Peak non-repetitive surge t _p =10ms, V _{RM} =0.6V _{RRM} , (note 5)	12.7	kA
I _{TSM2}	Peak non-repetitive surge t _p =10ms, V _{RM} ≤10V, (note 5)	14.0	kA
I ² t	I ² t capacity for fusing t _p =10ms, V _{RM} =0.6V _{RRM} , (note 5)	806×10 ³	A ² s
I ² t	I ² t capacity for fusing t _p =10ms, V _{RM} ≤10V, (note 5)	980×10 ³	A ² s
(di/dt) _{cr}	Maximum rate of rise of on-state current (repetitive), (Note 6)	500	A/μs
	Maximum rate of rise of on-state current (non-repetitive), (Note 6)	1000	A/μs
V _{RGM}	Peak reverse gate voltage	5	V
P _{G(AV)}	Mean forward gate power	4	W
P _{GM}	Peak forward gate power	30	W
V _{GD}	Non-trigger gate voltage, (Note 7)	0.25	V
T _{HS}	Operating temperature range	-40 to +130	°C
T _{stg}	Storage temperature range	-40 to +150	°C

Notes: -

- De-rating factor of 0.13% per °C is applicable for T_j below 25°C.
- Double side cooled, single phase; 50Hz, 180° half-sinewave.
- Single side cooled, single phase; 50Hz, 180° half-sinewave.
- Double side cooled.
- Half-sinewave, 130°C T_j initial.
- V_D=67% V_{DRM}, I_{FG}=2A, t_r≤0.5μs, T_{case}=130°C.
- Rated V_{DRM}.

Characteristics

	PARAMETER	MIN.	TYP.	MAX.	TEST CONDITIONS (Note 1)	UNITS
V _{TM}	Maximum peak on-state voltage	-	-	1.60	I _{TM} =1700A	V
V _{TM}	Maximum peak on-state voltage	-	-	2.34	I _{TM} =3700A	V
V ₀	Threshold voltage	-	-	0.973		V
r _s	Slope resistance	-	-	0.369		mΩ
dv/dt	Critical rate of rise of off-state voltage	1000	-	-	V _D =80% V _{DRM} , Linear ramp, gate o/c	V/μs
I _{DRM}	Peak off-state current	-	-	100	Rated V _{DRM}	mA
I _{R RM}	Peak reverse current	-	-	100	Rated V _{R RM}	mA
V _{GT}	Gate trigger voltage	-	-	3.0	T _J =25°C, V _D =10V, I _T =3A	V
I _{GT}	Gate trigger current	-	-	300		mA
I _H	Holding current	-	-	1000	T _J =25°C	mA
R _{thJK}	Thermal resistance, junction to heatsink	-	-	0.032	Double side cooled	K/W
		-	-	0.064	Cathode side cooled	
F	Mounting force	10	-	20	(Note 3)	kN
W _t	Weight	-	340	-		g

Notes: -

 1) Unless otherwise stated T_J=130°C.

Notes on Ratings and Characteristics

1.0 Voltage Grade Table

Voltage Grade	V_{DRM} V_{DSM} V_{RRM} V	V_{RSM} V	V_D V_R DC V
16	1600	1700	960
18	1800	1900	1080

2.0 Extension of Voltage Grades

This report is applicable to other and higher voltage grades when supply has been agreed by Sales/Production.

3.0 De-rating Factor

A blocking voltage de-rating factor of 0.13%/°C is applicable to this device for T_j below 25°C.

4.0 Repetitive dv/dt

Standard dv/dt is 1000V/μs.

5.0 Snubber Components

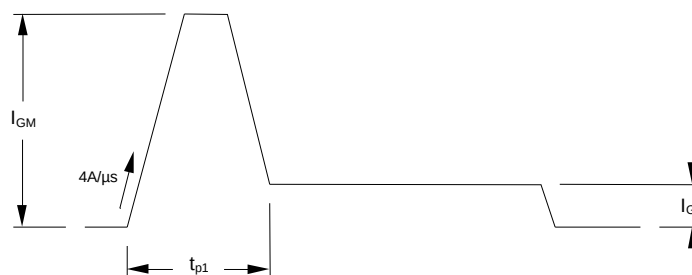
When selecting snubber components, care must be taken not to use excessively large values of snubber capacitor or excessively small values of snubber resistor. Such excessive component values may lead to device damage due to the large resultant values of snubber discharge current. If required, please consult the factory for assistance.

6.0 Rate of rise of on-state current

The maximum un-primed rate of rise of on-state current must not exceed 1000A/μs at any time during turn-on on a non-repetitive basis. For repetitive performance, the on-state rate of rise of current must not exceed 500A/μs at any time during turn-on. Note that these values of rate of rise of current apply to the total device current including that from any local snubber network.

7.0 Gate Drive

The nominal requirement for a typical gate drive is illustrated below. An open circuit voltage of at least 30V is assumed. This gate drive must be applied when using the full di/dt capability of the device.



The magnitude of I_{GM} should be between five and ten times I_{GT} , which is shown on page 2. Its duration (t_{p1}) should be 20μs or sufficient to allow the anode current to reach ten times I_L , whichever is greater. Otherwise, an increase in pulse current could be needed to supply the necessary charge to trigger. The 'back-porch' current I_G should remain flowing for the same duration as the anode current and have a magnitude in the order of 1.5 times I_{GT} .

8.0 Computer Modelling Parameters

8.1 Device Dissipation Calculations

$$I_{AV} = \frac{-V_0 + \sqrt{V_0^2 + 4 \cdot ff^2 \cdot r_s \cdot W_{AV}}}{2 \cdot ff^2 \cdot r_s} \quad \text{and:} \quad W_{AV} = \frac{\Delta T}{R_{th}}$$

$$\Delta T = T_{j \max} - T_{Hs}$$

Where $V_0=0.973V$, $r_s=0.369m\Omega$,

R_{th} = Supplementary thermal impedance, see table below.

ff = Form factor, see table below.

Supplementary Thermal Impedance							
Conduction Angle	30°	60°	90°	120°	180°	270°	d.c.
Square wave Double Side Cooled	0.048	0.0436	0.0413	0.0388	0.036	0.0345	0.032
Square wave Cathode Side Cooled	0.079	0.0769	0.074	0.0716	0.0688	0.0665	0.064
Sine wave Double Side Cooled	0.0415	0.0394	0.0378	0.0355	0.032		
Sine wave Cathode Side Cooled	0.0735	0.0718	0.07	0.0679	0.064		

Form Factors							
Conduction Angle	30°	60°	90°	120°	180°	270°	d.c.
Square wave	3.46	2.45	2	1.73	1.41	1.15	1
Sine wave	3.98	2.78	2.22	1.88	1.57		

8.2 Calculating V_T using ABCD Coefficients

The on-state characteristic I_T vs. V_T , on page 5 is represented in two ways.

- the well-established V_0 and r_s tangent used for rating purposes and
- a set of constants A, B, C, D, forming the coefficients of the representative equation for V_T in terms of I_T given below:

$$V_T = A + B \cdot \ln(I_T) + C \cdot I_T + D \cdot \sqrt{I_T}$$

The constants, derived by curve fitting software, are given below for both hot and cold characteristics. The resulting values for V_T agree with the true device characteristic over a current range, which is limited to that plotted.

25°C Coefficients		130°C Coefficients	
A	0.67375692	A	0.667090504
B	0.078282059	B	0.050891009
C	2.652313×10^{-4}	C	3.575361×10^{-4}
D	-0.00264381	D	-0.001175842

8.3 D.C. Thermal Impedance Calculation

$$r_t = \sum_{p=1}^{p=n} r_p \cdot \left(1 - e^{\frac{-t}{\tau_p}} \right)$$

Where $p = 1$ to n , n is the number of terms in the series and:

- t = Duration of heating pulse in seconds.
 r_t = Thermal resistance at time t .
 r_p = Amplitude of p^{th} term.
 τ_p = Time Constant of r_{th} term.

D.C. Double Side Cooled				
Term	1	2	3	4
r_p	0.01771901	4.240625×10^{-3}	6.963806×10^{-3}	3.043661×10^{-3}
τ_p	0.7085781	0.1435833	0.03615196	2.130842×10^{-3}

D.C. Cathode Side Cooled					
Term	1	2	3	4	5
r_p	0.03947164	0.01022837	8.789912×10^{-3}	4.235162×10^{-3}	1.907609×10^{-3}
τ_p	4.090062	1.078983	0.08530917	0.01128791	1.240861×10^{-3}

Curves

Figure 1 - On-state characteristics of Limit device

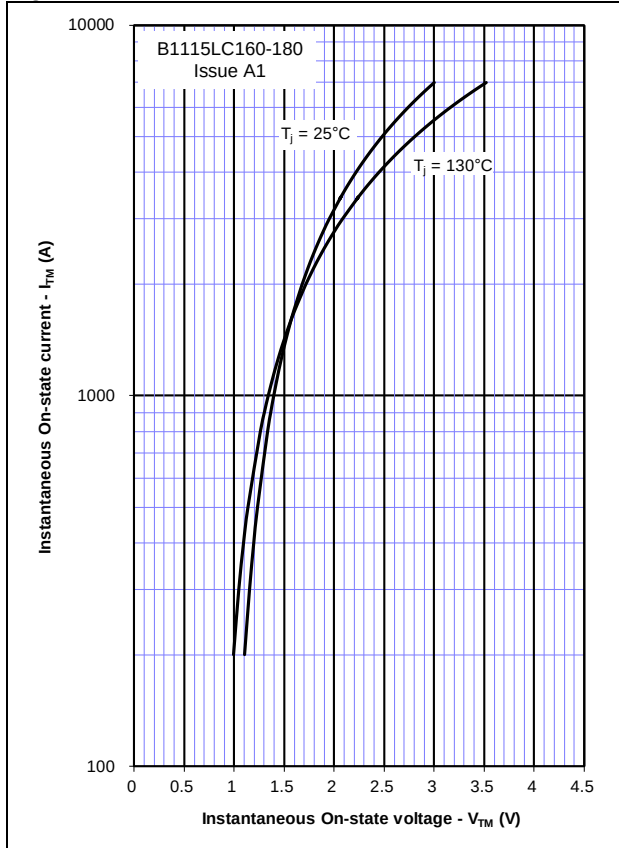


Figure 2 - Transient Thermal Impedance

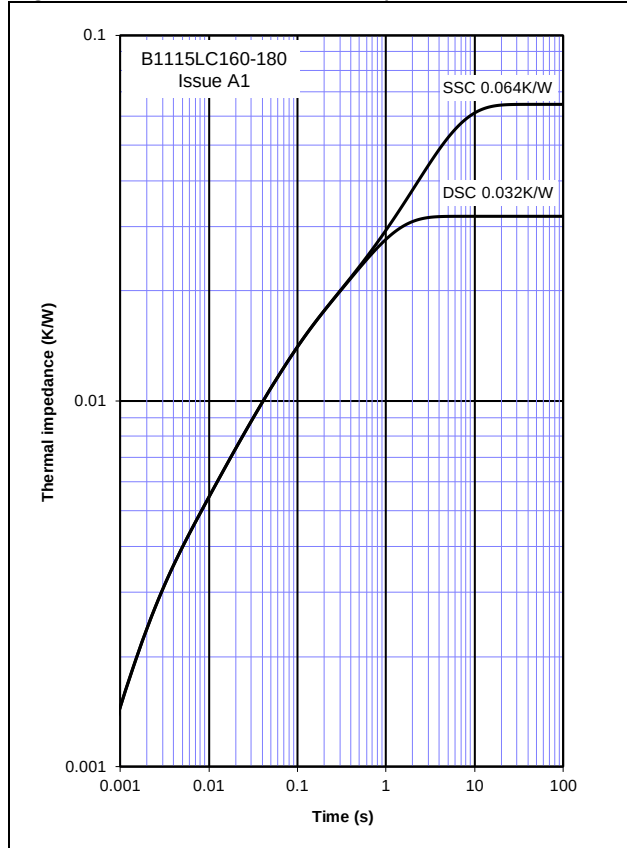


Figure 3 - Gate Characteristics - Trigger Limits

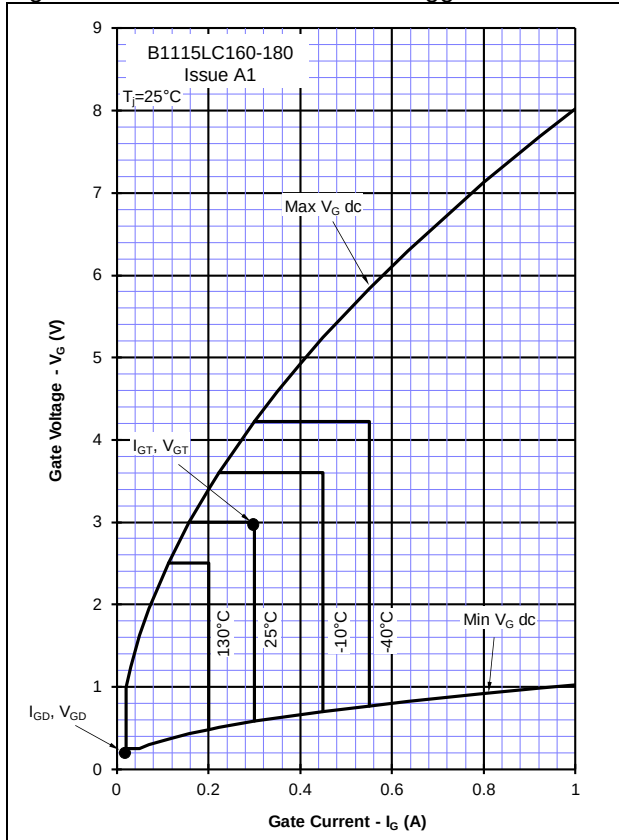


Figure 4 - Gate Characteristics - Power Curves

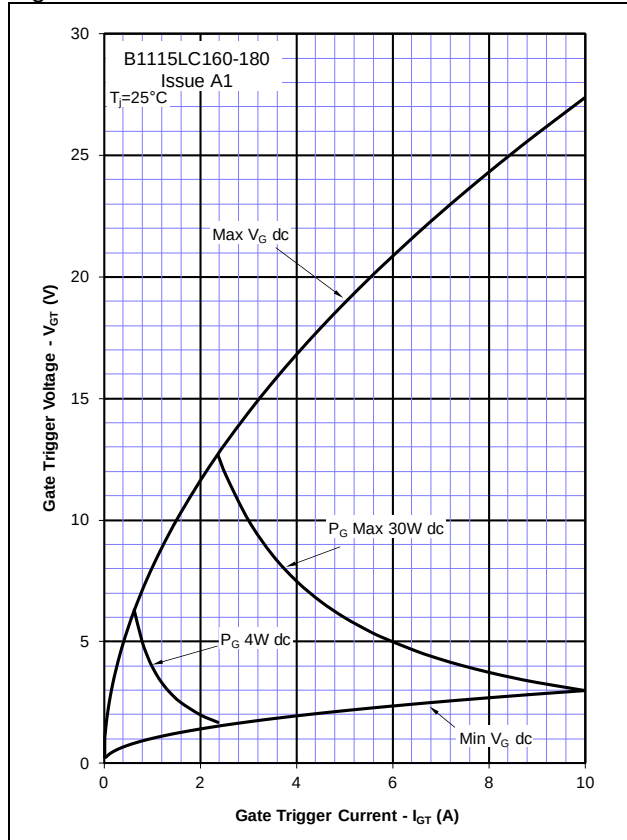


Figure 5 – On-state current vs. Power dissipation – Double Side Cooled (Sine wave)

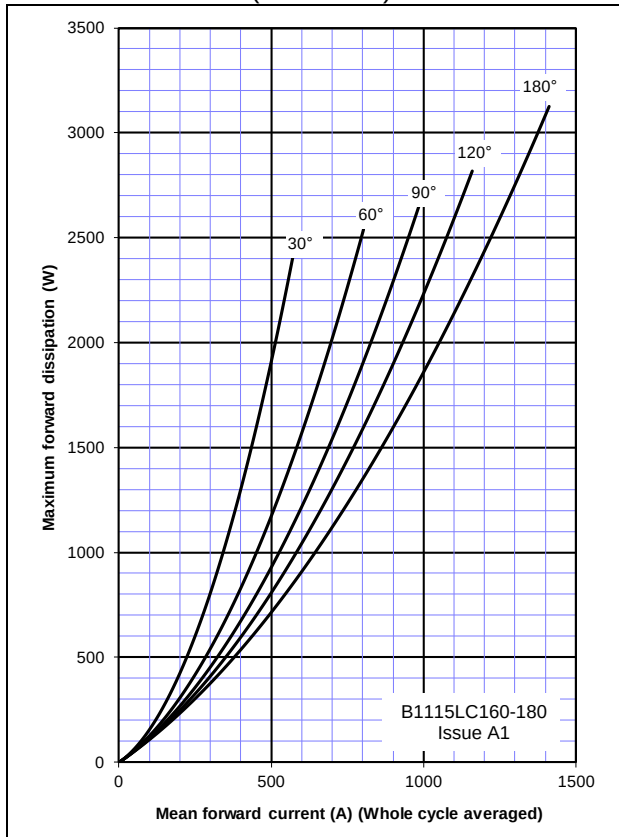


Figure 6 – On-state current vs. Heatsink temperature - Double Side Cooled (Sine wave)

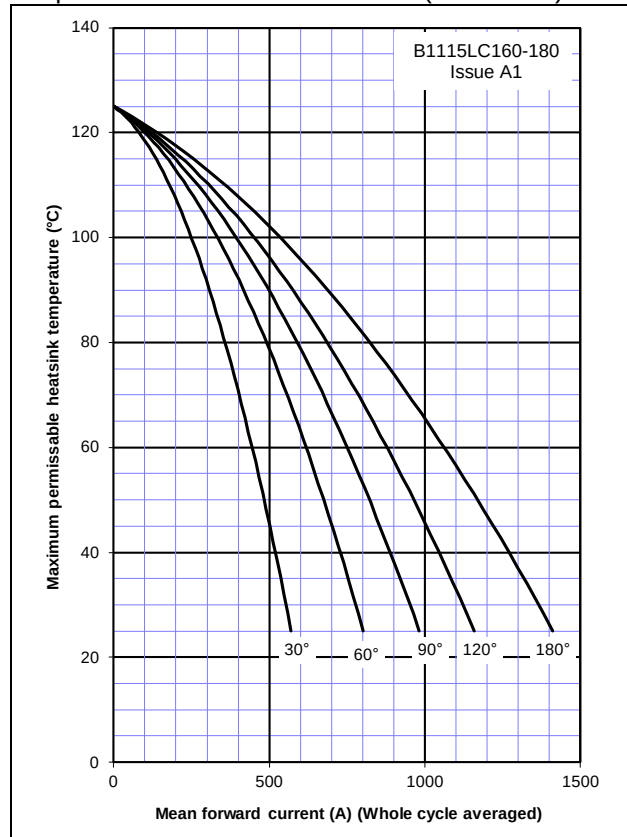


Figure 7 – On-state current vs. Power dissipation – Double Side Cooled (Square wave)

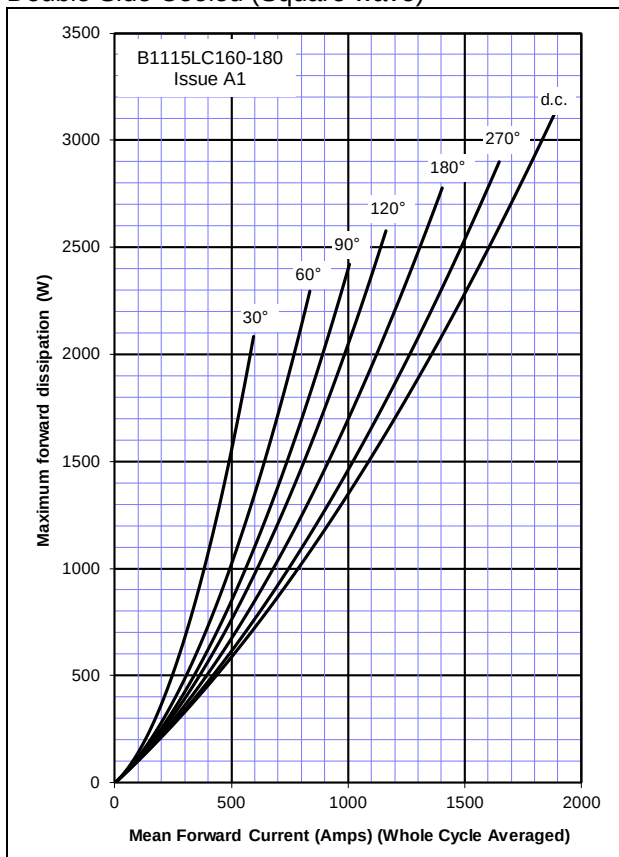


Figure 8 – On-state current vs. Heatsink temperature - Double Side Cooled (Square wave)

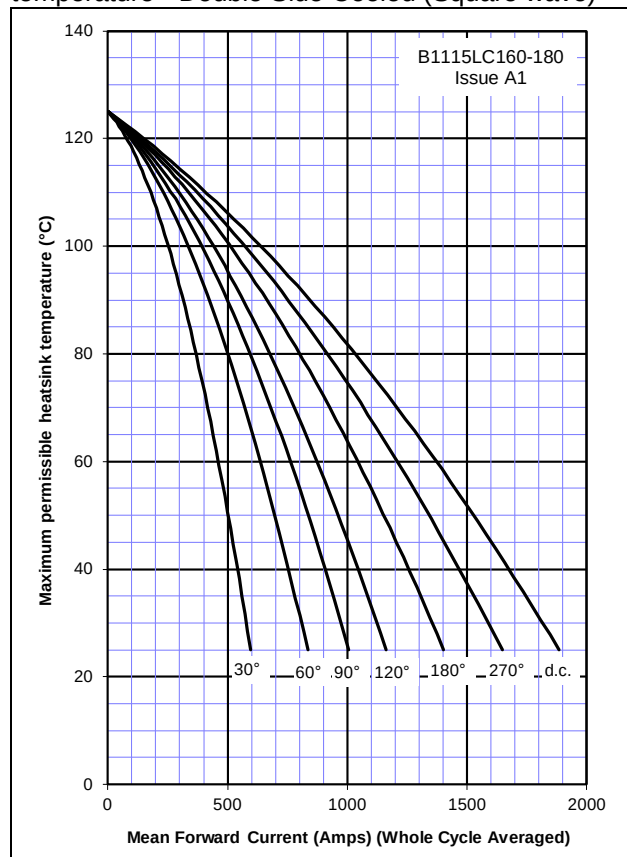


Figure 9 – On-state current vs. Power dissipation – Single Side Cooled (Sine wave)

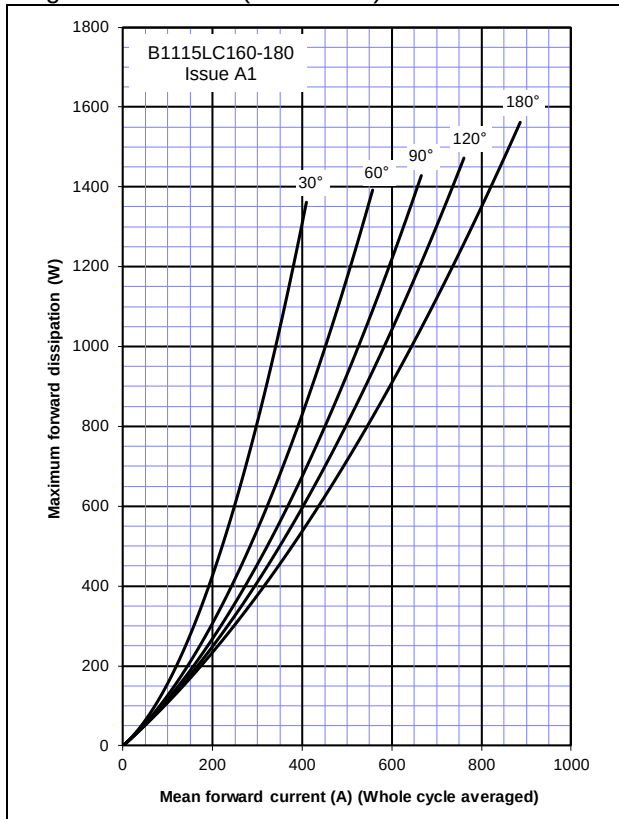


Figure 10 – On-state current vs. Heatsink temperature - Single Side Cooled (Sine wave)

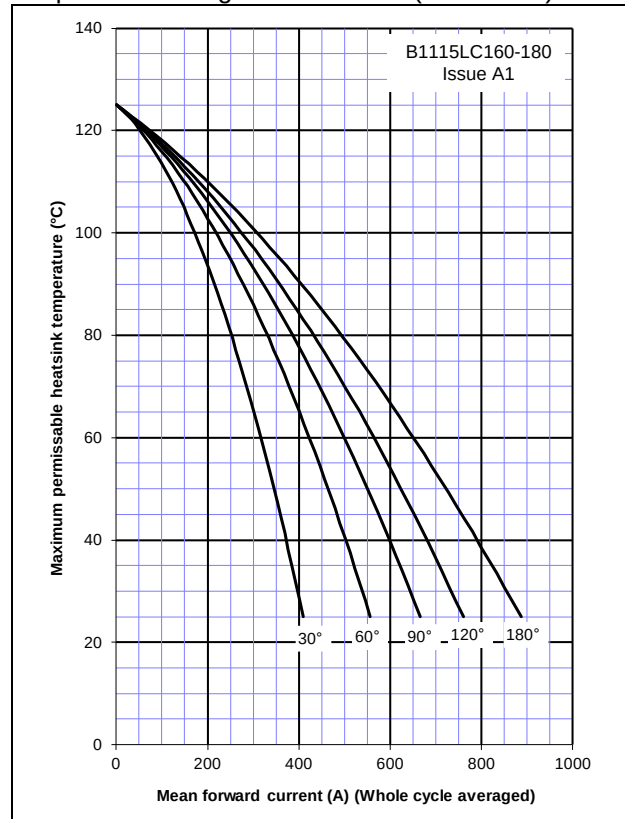


Figure 11 – On-state current vs. Power dissipation – Single Side Cooled (Square wave)

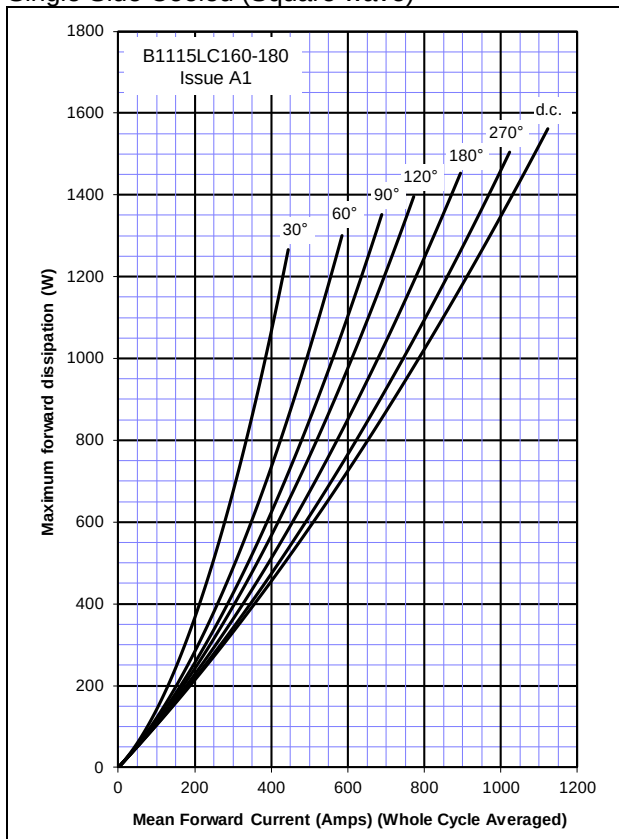


Figure 12 – On-state current vs. Heatsink temperature - Single Side Cooled (Square wave)

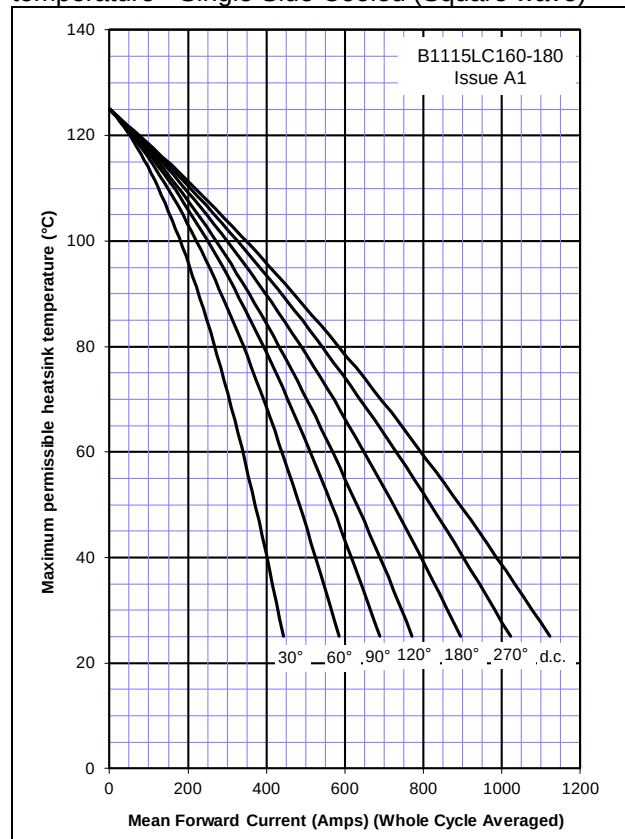
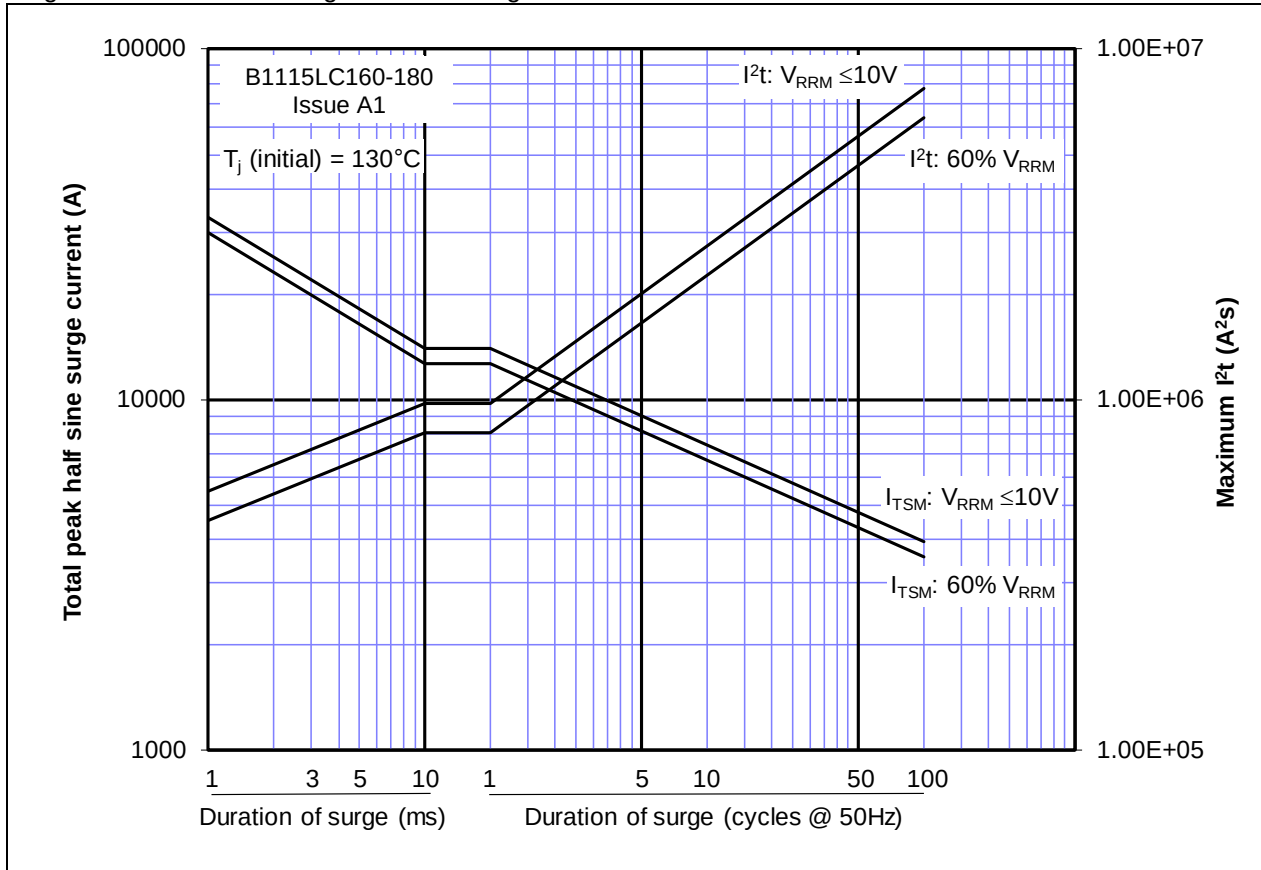
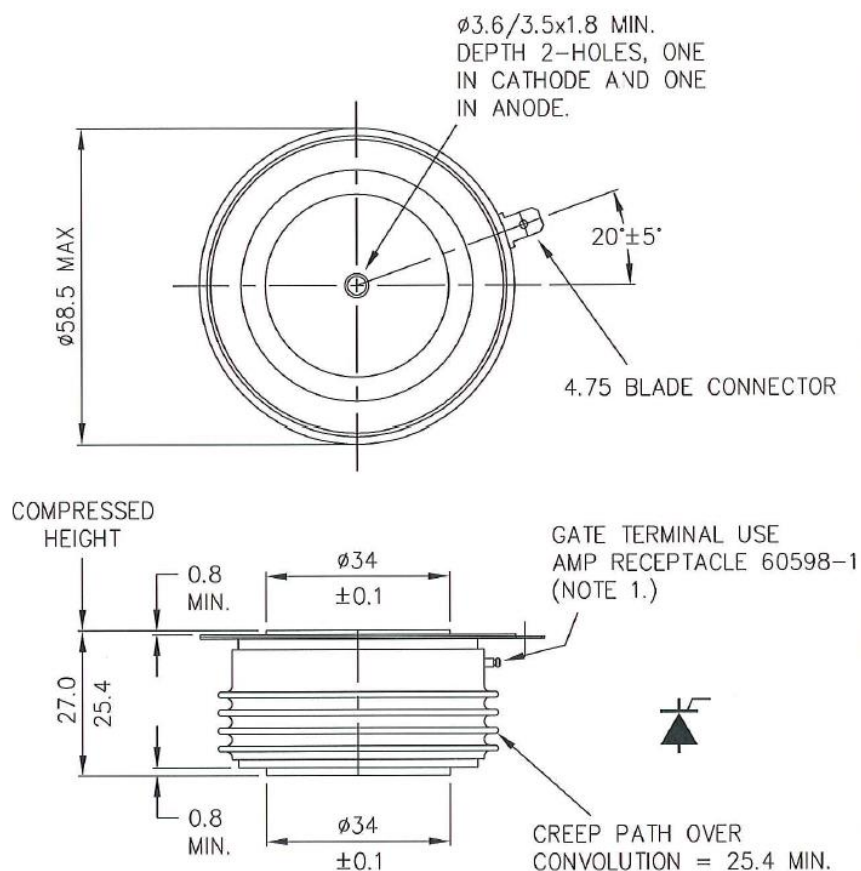


Figure 13 – Maximum surge and I^2t Ratings



Outline Drawing & Ordering Information



ORDERING INFORMATION

(Please quote 10-digit code as below)

B1115	LC	♦ ♦	0
Fixed Type Code	Fixed Outline Code	Voltage Code 16 & 18	Fixed turn-off time code

 Typical order code: B1115LC180 – 1800V V_{DRM} , V_{RRM} , 1000V/ μ s dv/dt, 26mm clamp height capsule.

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 Langley Park Way,
 Langley Park,
 Chippenham,
 Wiltshire, SN15 1GE.
 Tel: +44 (0)1249 444524
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<https://www.littelfuse.com/contactus.aspx>



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